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Details

Product Status	Obsolete
Core Processor	ST7
Core Size	8-Bit
Speed	16MHz
Connectivity	SPI
Peripherals	LVD, POR, PWM, WDT
Number of I/O	22
Program Memory Size	8KB (8K x 8)
Program Memory Type	FLASH
EEPROM Size	-
RAM Size	256 x 8
Voltage - Supply (Vcc/Vdd)	3.2V ~ 5.5V
Data Converters	A/D 6x8b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 85°C (TA)
Mounting Type	Through Hole
Package / Case	32-SDIP (0.400", 10.16mm)
Supplier Device Package	-
Purchase URL	https://www.e-xfl.com/product-detail/stmicroelectronics/st72c215g2b6

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2 PIN DESCRIPTION

Figure 2. 28-Pin SO Package Pinout

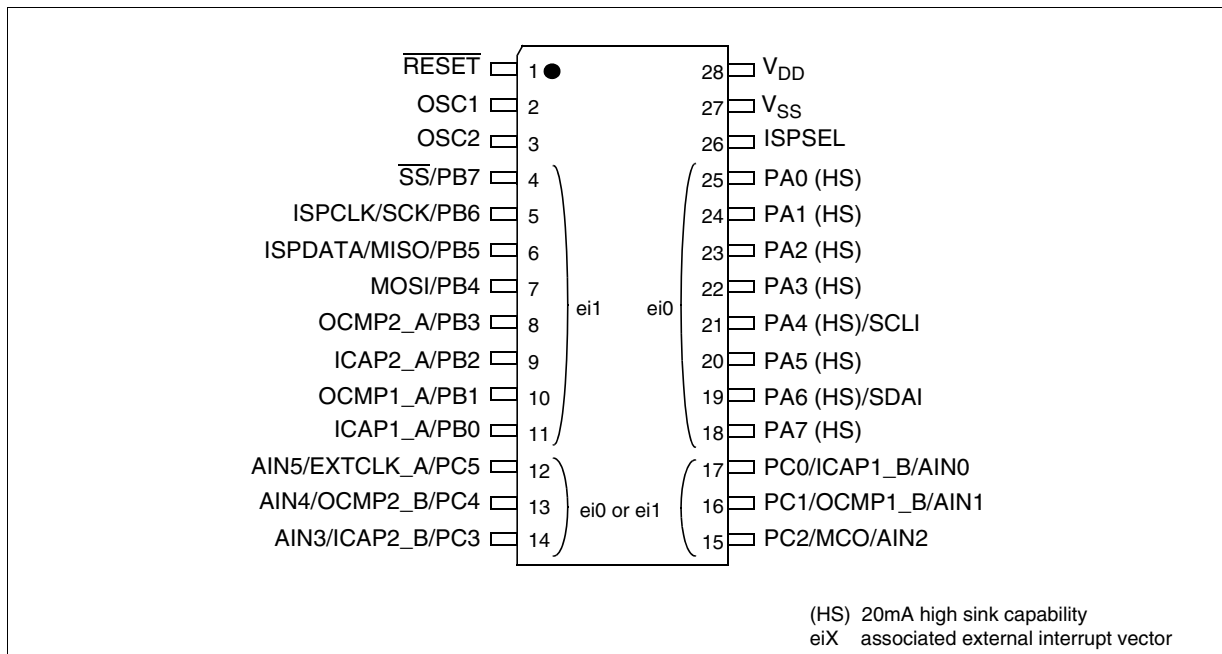
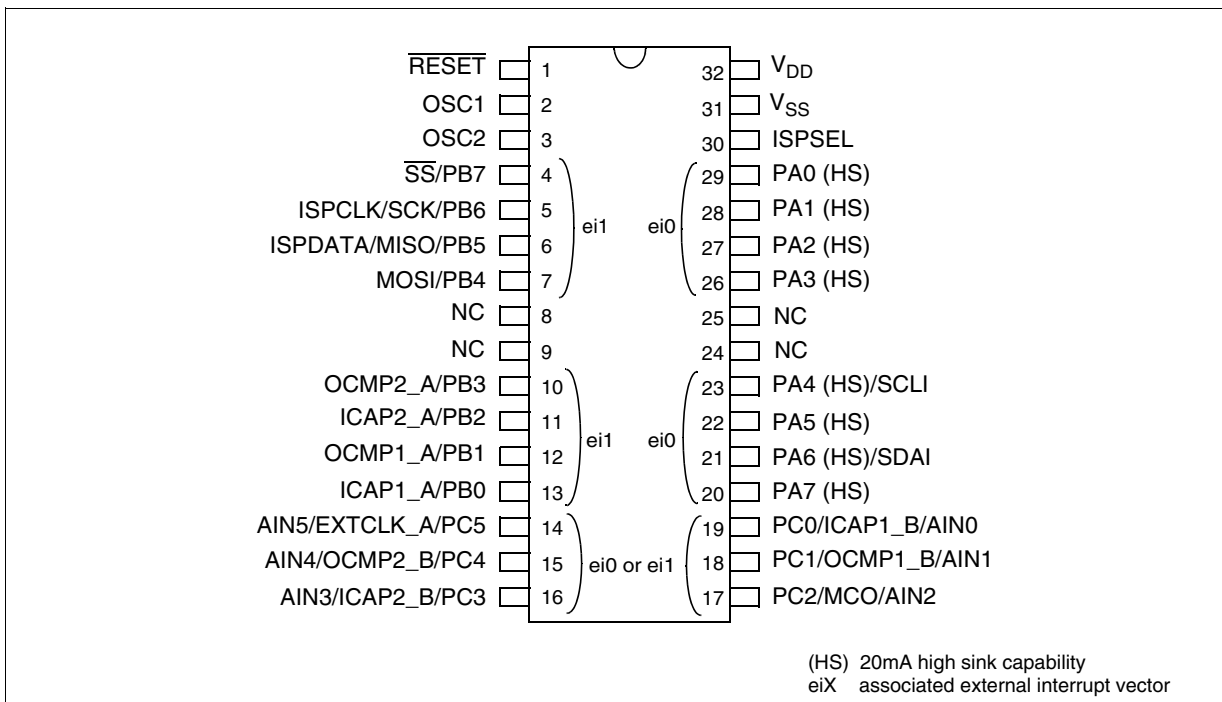


Figure 3. 32-Pin SDIP Package Pinout



Pin n°		Pin Name	Type	Level		Port / Control						Main Function (after reset)	Alternate Function
SDIP32	SO28			Input	Output	Input				Output			
						float	wpu	int	ana	OD	PP		
18	16	PC1/OCMP1_B/AIN1	I/O	C _T	X	ei0/ei1		X	X	X	Port C1	Timer B Output Compare 1 or ADC Analog Input 1	
19	17	PC0/ICAP1_B/AIN0	I/O	C _T	X	ei0/ei1		X	X	X	Port C0	Timer B Input Capture 1 or ADC Analog Input 0	
20	18	PA7	I/O	C _T	HS	X	ei0			X	X	Port A7	
21	19	PA6 /SDAI	I/O	C _T	HS	X		ei0		T		Port A6	I ² C Data
22	20	PA5	I/O	C _T	HS	X	ei0			X	X	Port A5	
23	21	PA4 /SCLI	I/O	C _T	HS	X		ei0		T		Port A4	I ² C Clock
24		NC	Not Connected										
25		NC											
26	22	PA3	I/O	C _T	HS	X	ei0			X	X	Port A3	
27	23	PA2	I/O	C _T	HS	X	ei0			X	X	Port A2	
28	24	PA1	I/O	C _T	HS	X	ei0			X	X	Port A1	
29	25	PA0	I/O	C _T	HS	X	ei0			X	X	Port A0	
30	26	ISPSEL	I	C		X						In situ programming selection (Should be tied low in standard user mode).	
31	27	V _{SS}	S									Ground	
32	28	V _{DD}	S									Main power supply	

Notes:

1. In the interrupt input column, “eiX” defines the associated external interrupt vector. If the weak pull-up column (wpu) is merged with the interrupt column (int), then the I/O configuration is pull-up interrupt input, else the configuration is floating interrupt input.

2. In the open drain output column, “T” defines a true open drain I/O (P-Buffer and protection diode to V_{DD} are not implemented). See Section 9 "I/O PORTS" on page 30 and Section 13.8 "I/O PORT PIN CHARACTERISTICS" on page 118 for more details.

3. OSC1 and OSC2 pins connect a crystal or ceramic resonator, an external RC, or an external source to the on-chip oscillator see Section 2 "PIN DESCRIPTION" on page 7 and Section 13.5 "CLOCK AND TIMING CHARACTERISTICS" on page 105 for more details.

Address	Block	Register Label	Register Name	Reset Status	Remarks
0031h	TIMER A	TACR2	Timer A Control Register 2	00h	R/W
0032h		TACR1	Timer A Control Register 1	00h	R/W
0033h		TASR	Timer A Status Register	xxh	Read Only
0034h		TAIC1HR	Timer A Input Capture 1 High Register	xxh	Read Only
0035h		TAIC1LR	Timer A Input Capture 1 Low Register	xxh	Read Only
0036h		TAOC1HR	Timer A Output Compare 1 High Register	80h	R/W
0037h		TAOC1LR	Timer A Output Compare 1 Low Register	00h	R/W
0038h		TACHR	Timer A Counter High Register	FFh	Read Only
0039h		TACLR	Timer A Counter Low Register	FCh	Read Only
003Ah		TAACHR	Timer A Alternate Counter High Register	FFh	Read Only
003Bh		TAACLR	Timer A Alternate Counter Low Register	FCh	Read Only
003Ch		TAIC2HR	Timer A Input Capture 2 High Register	xxh	Read Only
003Dh		TAIC2LR	Timer A Input Capture 2 Low Register	xxh	Read Only
003Eh		TAOC2HR	Timer A Output Compare 2 High Register	80h	R/W
003Fh		TAOC2LR	Timer A Output Compare 2 Low Register	00h	R/W
0040h		MISCR2	Miscellaneous Register 2	00h	R/W
0041h	TIMER B	TBCR2	Timer B Control Register 2	00h	R/W
0042h		TBCR1	Timer B Control Register 1	00h	R/W
0043h		TBSR	Timer B Status Register	xxh	Read Only
0044h		TBIC1HR	Timer B Input Capture 1 High Register	xxh	Read Only
0045h		TBIC1LR	Timer B Input Capture 1 Low Register	xxh	Read Only
0046h		TBOC1HR	Timer B Output Compare 1 High Register	80h	R/W
0047h		TBOC1LR	Timer B Output Compare 1 Low Register	00h	R/W
0048h		TBCHR	Timer B Counter High Register	FFh	Read Only
0049h		TBCLR	Timer B Counter Low Register	FCh	Read Only
004Ah		TBACHR	Timer B Alternate Counter High Register	FFh	Read Only
004Bh		TBACLR	Timer B Alternate Counter Low Register	FCh	Read Only
004Ch		TBIC2HR	Timer B Input Capture 2 High Register	xxh	Read Only
004Dh		TBIC2LR	Timer B Input Capture 2 Low Register	xxh	Read Only
004Eh		TBOC2HR	Timer B Output Compare 2 High Register	80h	R/W
004Fh		TBOC2LR	Timer B Output Compare 2 Low Register	00h	R/W
0050h to 006Fh	Reserved (32 Bytes)				
0070h	ADC	ADCDR	Data Register	00h	Read Only
0071h		ADCCSR	Control/Status Register	00h	R/W
0072h to 007Fh	Reserved (14 Bytes)				

Legend: x=undefined, R/W=read/write

Notes:

1. The contents of the I/O port DR registers are readable only in output configuration. In input configuration, the values of the I/O pins are returned instead of the DR register contents.
2. The bits associated with unavailable pins must always keep their reset value.

6.3 MULTI-OSCILLATOR (MO)

The main clock of the ST7 can be generated by four different source types coming from the multi-oscillator block:

- an external source
- 4 crystal or ceramic resonator oscillators
- an external RC oscillator
- an internal high frequency RC oscillator

Each oscillator is optimized for a given frequency range in terms of consumption and is selectable through the option byte. The associated hardware configuration are shown in Table 3. Refer to the electrical characteristics section for more details.

External Clock Source

In this external clock mode, a clock signal (square, sinus or triangle) with ~50% duty cycle has to drive the OSC1 pin while the OSC2 pin is tied to ground.

Crystal/Ceramic Oscillators

This family of oscillators has the advantage of producing a very accurate rate on the main clock of the ST7. The selection within a list of 4 oscillators with different frequency ranges has to be done by option byte in order to reduce consumption. In this mode of the multi-oscillator, the resonator and the load capacitors have to be placed as close as possible to the oscillator pins in order to minimize output distortion and start-up stabilization time. The loading capacitance values must be adjusted according to the selected oscillator.

These oscillators are not stopped during the RESET phase to avoid losing time in the oscillator start-up phase.

External RC Oscillator

This oscillator allows a low cost solution for the main clock of the ST7 using only an external resistor and an external capacitor. The frequency of the external RC oscillator (in the range of some MHz.) is fixed by the resistor and the capacitor values. Consequently in this MO mode, the accuracy of the clock is dependent on V_{DD} , T_A , process variations and the accuracy of the discrete components used. This option should not be used in applications that require accurate timing.

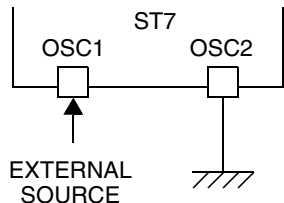
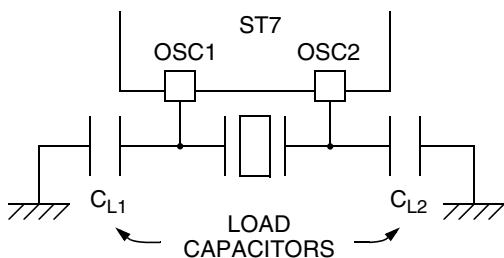
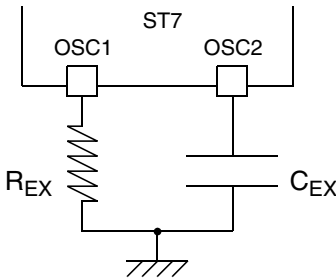
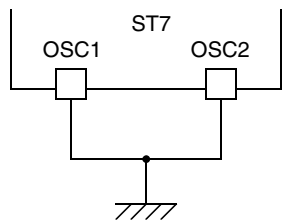
Internal RC Oscillator

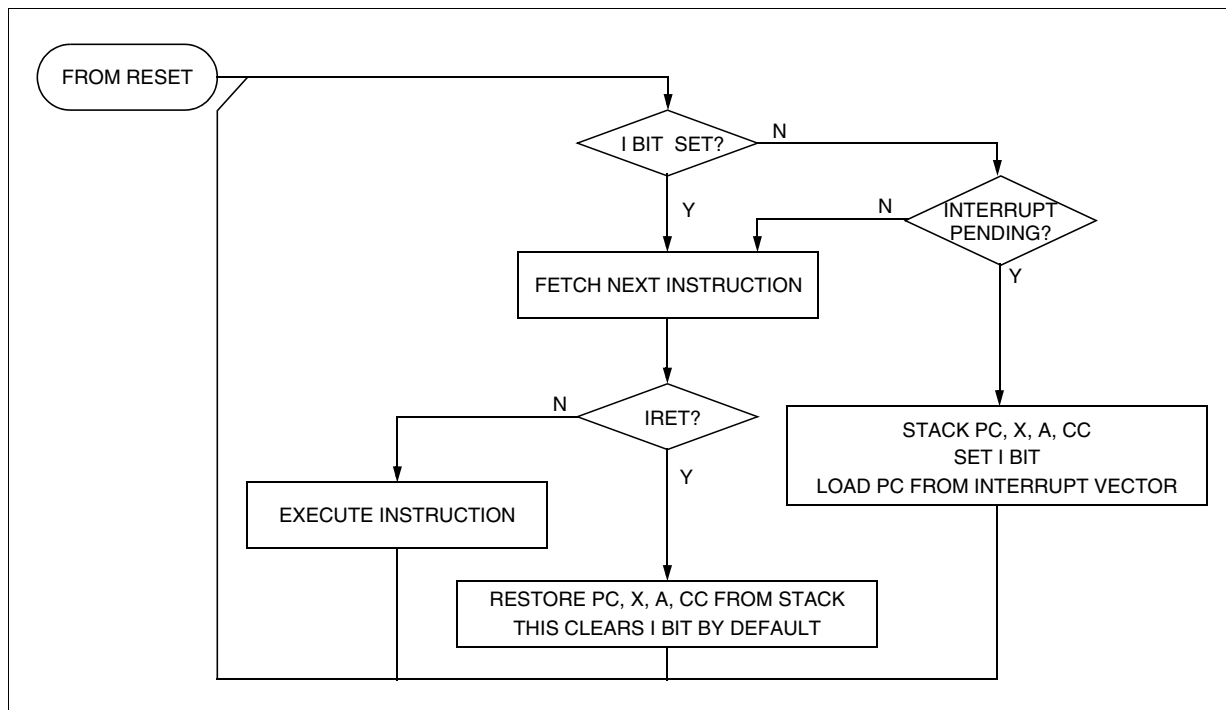
The internal RC oscillator mode is based on the same principle as the external RC oscillator including the resistance and the capacitance of the device. This mode is the most cost effective one with the drawback of a lower frequency accuracy. Its frequency is in the range of several MHz. This op-

tion should not be used in applications that require accurate timing.

In this mode, the two oscillator pins have to be tied to ground.

Table 3. ST7 Clock Sources

	Hardware Configuration
External Clock	
Crystal/Ceramic Resonators	
External RC Oscillator	
Internal RC Oscillator	

INTERRUPTS (Cont'd)**Figure 15. Interrupt Processing Flowchart****Table 5. Interrupt Mapping**

N°	Source Block	Description	Register Label	Priority Order	Exit from HALT	Address Vector
	RESET	Reset	N/A	Highest Priority	yes	FFFEh-FFFFh
	TRAP	Software Interrupt			no	FFFC h-FFFDh
0	ei0	External Interrupt Port A7..0 (C5..0 ¹)			yes	FFFAh-FFFBh
1	ei1	External Interrupt Port B7..0 (C5..0 ¹)				FFF8h-FFF9h
2	CSS	Clock Security System Interrupt	CRSR	↓	no	FFF6h-FFF7h
3	SPI	SPI Peripheral Interrupts	SPISR			FFF4h-FFF5h
4	TIMER A	TIMER A Peripheral Interrupts	TASR			FFF2h-FFF3h
5		Not used			no	FFF0h-FFF1h
6	TIMER B	TIMER B Peripheral Interrupts	TBSR			FFEEh-FFEFh
7		Not used				FFEC h-FFEDh
8		Not used				FFEAh-FFEBh
9		Not used				FFE8h-FFE9h
10		Not used				FFE6h-FFE7h
11	I ² C	I ² C Peripheral Interrupt	I2CSRx		no	FFE4h-FFE5h
12		Not Used		Lowest Priority		FFE2h-FFE3h
13		Not Used				FFE0h-FFE1h

Note

1. Configurable by option byte.

POWER SAVING MODES (Cont'd)

8.3 WAIT MODE

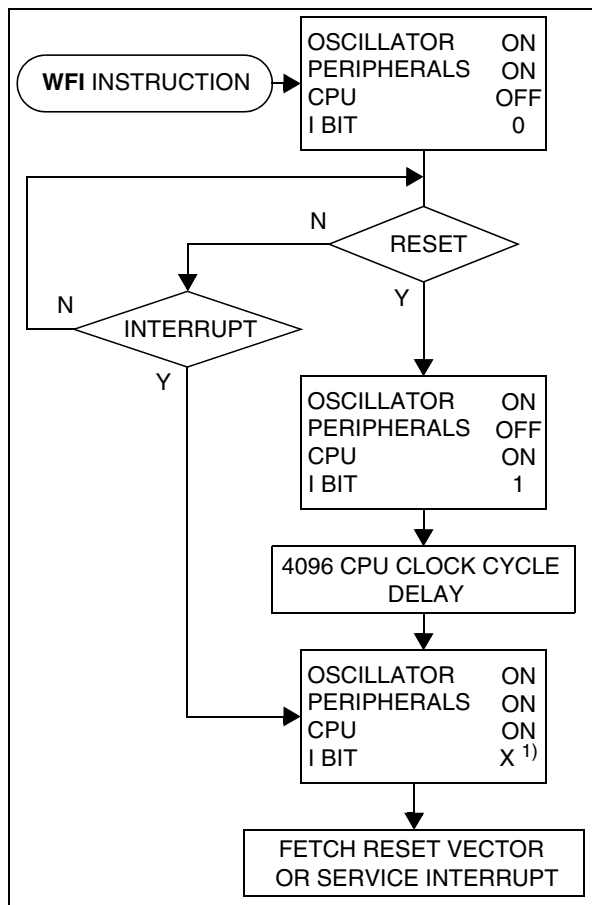
WAIT mode places the MCU in a low power consumption mode by stopping the CPU.

This power saving mode is selected by calling the "WFI" ST7 software instruction.

All peripherals remain active. During WAIT mode, the I bit of the CC register is forced to 0, to enable all interrupts. All other registers and memory remain unchanged. The MCU remains in WAIT mode until an interrupt or Reset occurs, whereupon the Program Counter branches to the starting address of the interrupt or Reset service routine. The MCU will remain in WAIT mode until a Reset or an Interrupt occurs, causing it to wake up.

Refer to Figure 18.

Figure 18. WAIT Mode Flow-chart



Note:

1. Before servicing an interrupt, the CC register is pushed on the stack. The I bit of the CC register is set during the interrupt routine and cleared when the CC register is popped.

11.2 16-BIT TIMER

11.2.1 Introduction

The timer consists of a 16-bit free-running counter driven by a programmable prescaler.

It may be used for a variety of purposes, including measuring the pulse lengths of up to two input signals (*input capture*) or generating up to two output waveforms (*output compare* and *PWM*).

Pulse lengths and waveform periods can be modulated from a few microseconds to several milliseconds using the timer prescaler and the CPU clock prescaler.

Some ST7 devices have two on-chip 16-bit timers. They are completely independent, and do not share any resources. They are synchronized after a MCU reset as long as the timer clock frequencies are not modified.

This description covers one or two 16-bit timers. In ST7 devices with two timers, register names are prefixed with TA (Timer A) or TB (Timer B).

11.2.2 Main Features

- Programmable prescaler: f_{CPU} divided by 2, 4 or 8.
- Overflow status flag and maskable interrupt
- External clock input (must be at least 4 times slower than the CPU clock speed) with the choice of active edge
- Output compare functions with:
 - 2 dedicated 16-bit registers
 - 2 dedicated programmable signals
 - 2 dedicated status flags
 - 1 dedicated maskable interrupt
- Input capture functions with:
 - 2 dedicated 16-bit registers
 - 2 dedicated active edge selection signals
 - 2 dedicated status flags
 - 1 dedicated maskable interrupt
- Pulse Width Modulation mode (PWM)
- One Pulse mode
- 5 alternate functions on I/O ports (ICAP1, ICAP2, OCMP1, OCMP2, EXTCLK)*

The Block Diagram is shown in Figure 1.

***Note:** Some timer pins may not be available (not bonded) in some ST7 devices. Refer to the device pin out description.

When reading an input signal on a non-bonded pin, the value will always be '1'.

11.2.3 Functional Description

11.2.3.1 Counter

The main block of the Programmable Timer is a 16-bit free running upcounter and its associated 16-bit registers. The 16-bit registers are made up of two 8-bit registers called high and low.

Counter Register (CR)

- Counter High Register (CHR) is the most significant byte (MS Byte).
- Counter Low Register (CLR) is the least significant byte (LS Byte).

Alternate Counter Register (ACR)

- Alternate Counter High Register (ACHR) is the most significant byte (MS Byte).
- Alternate Counter Low Register (ACLR) is the least significant byte (LS Byte).

These two read-only 16-bit registers contain the same value but with the difference that reading the ACLR register does not clear the TOF bit (Timer overflow flag), located in the Status register (SR). (See note at the end of paragraph titled 16-bit read sequence).

Writing in the CLR register or ACLR register resets the free running counter to the FFFCh value.

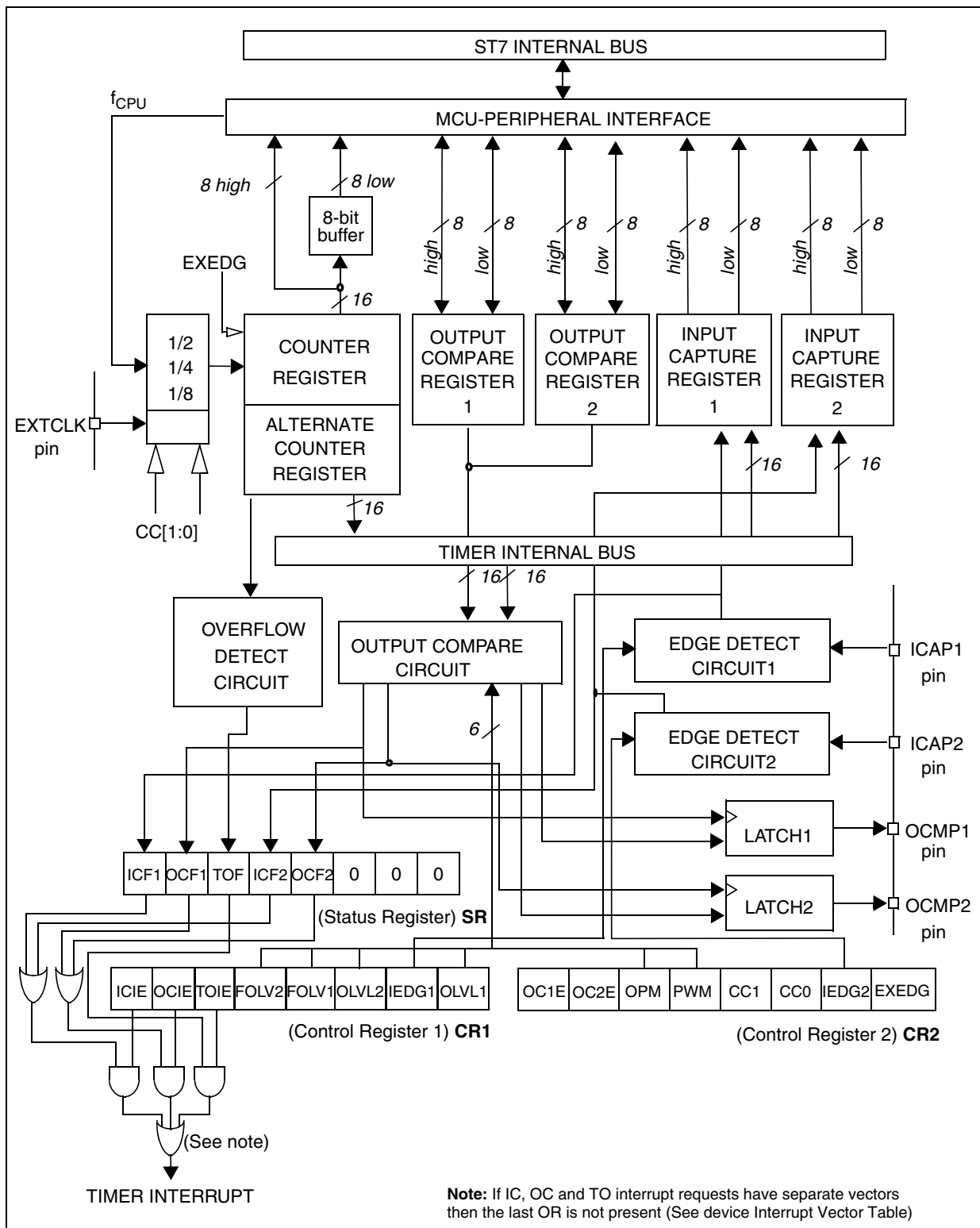
Both counters have a reset value of FFFCh (this is the only value which is reloaded in the 16-bit timer). The reset value of both counters is also FFFCh in One Pulse mode and PWM mode.

The timer clock depends on the clock control bits of the CR2 register, as illustrated in Table 1. The value in the counter register repeats every 131072, 262144 or 524288 CPU clock cycles depending on the CC[1:0] bits.

The timer frequency can be $f_{CPU}/2$, $f_{CPU}/4$, $f_{CPU}/8$ or an external frequency.

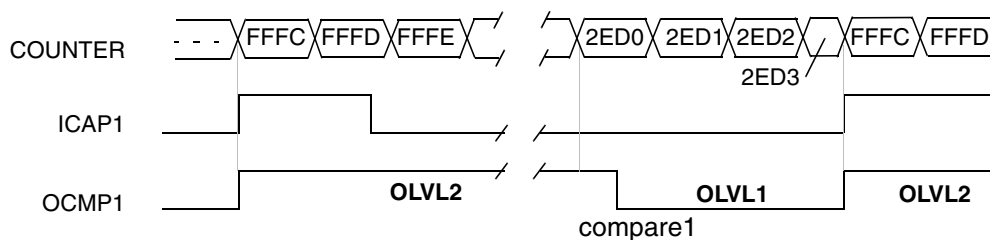
16-BIT TIMER (Cont'd)

Figure 26. Timer Block Diagram



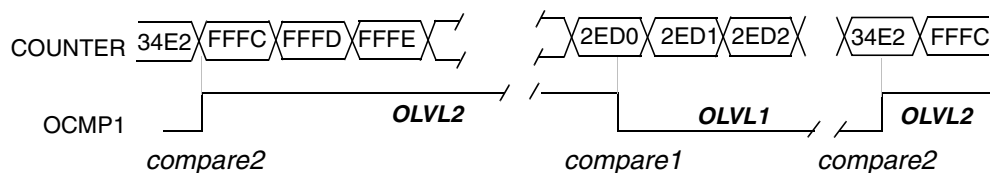
16-BIT TIMER (Cont'd)

Figure 35. One Pulse Mode Timing Example



Note: IEDG1 = 1, OC1R = 2ED0h, OLVL1 = 0, OLVL2 = 1

Figure 36. Pulse Width Modulation Mode Timing Example

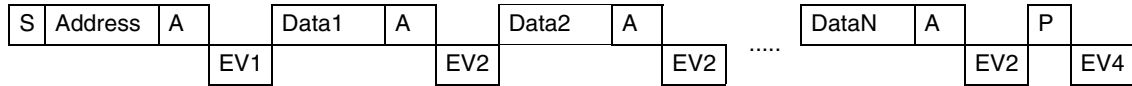


Note: OC1R = 2ED0h, OC2R = 34E2, OLVL1 = 0, OLVL2 = 1

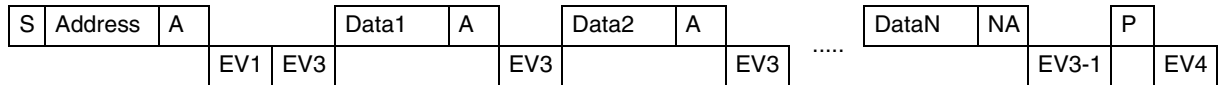
I²C BUS INTERFACE (Cont'd)

Figure 45. Transfer Sequencing

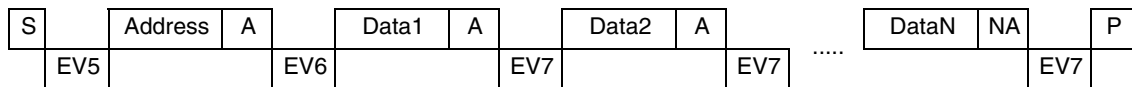
7-bit Slave receiver:



7-bit Slave transmitter:



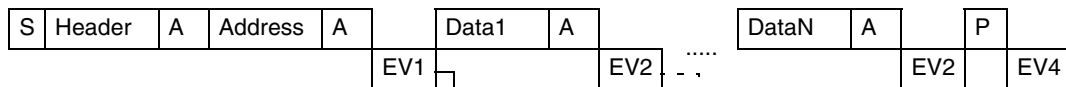
7-bit Master receiver:



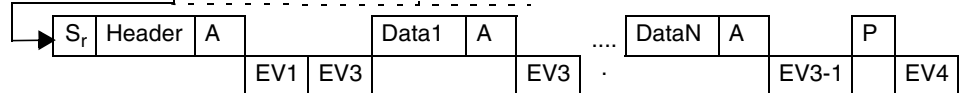
7-bit Master transmitter:



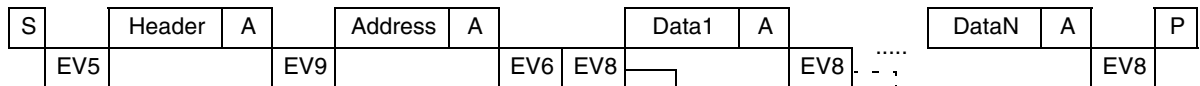
10-bit Slave receiver:



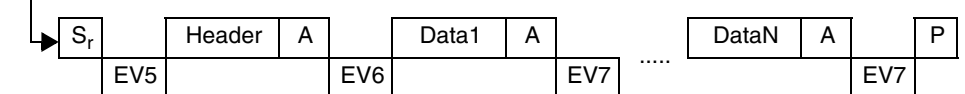
10-bit Slave transmitter:



10-bit Master transmitter



10-bit Master receiver:



Legend: S=Start, S_r = Repeated Start, P=Stop, A=Acknowledge, NA=Non-acknowledge, EVx=Event (with interrupt if ITE=1)

EV1: EVF=1, ADSL=1, cleared by reading SR1 register.

EV2: EVF=1, BTF=1, cleared by reading SR1 register followed by reading DR register.

EV3: EVF=1, BTF=1, cleared by reading SR1 register followed by writing DR register.

EV3-1: EVF=1, AF=1, BTF=1; AF is cleared by reading SR1 register. BTF is cleared by releasing the lines (STOP=1, STOP=0) or by writing DR register (DR=FFh). **Note:** If lines are released by STOP=1, STOP=0, the subsequent EV4 is not seen.

EV4: EVF=1, STOPF=1, cleared by reading SR2 register.

EV5: EVF=1, SB=1, cleared by reading SR1 register followed by writing DR register.

EV6: EVF=1, cleared by reading SR1 register followed by writing CR register (for example PE=1).

EV7: EVF=1, BTF=1, cleared by reading SR1 register followed by reading DR register.

EV8: EVF=1, BTF=1, cleared by reading SR1 register followed by writing DR register.

EV9: EVF=1, ADD10=1, cleared by reading SR1 register followed by writing DR register.

ST7 ADDRESSING MODES (Cont'd)**12.1.6 Indirect Indexed (Short, Long)**

This is a combination of indirect and short indexed addressing modes. The operand is referenced by its memory address, which is defined by the unsigned addition of an index register value (X or Y) with a pointer value located in memory. The pointer address follows the opcode.

The indirect indexed addressing mode consists of two sub-modes:

Indirect Indexed (Short)

The pointer address is a byte, the pointer size is a byte, thus allowing 00 - 1FE addressing space, and requires 1 byte after the opcode.

Indirect Indexed (Long)

The pointer address is a byte, the pointer size is a word, thus allowing 64 Kbyte addressing space, and requires 1 byte after the opcode.

Table 20. Instructions Supporting Direct, Indexed, Indirect and Indirect Indexed Addressing Modes

Long and Short Instructions	Function
LD	Load
CP	Compare
AND, OR, XOR	Logical Operations
ADC, ADD, SUB, SBC	Arithmetic Addition/subtraction operations
BCP	Bit Compare

Short Instructions Only	Function
CLR	Clear
INC, DEC	Increment/Decrement
TNZ	Test Negative or Zero
CPL, NEG	1 or 2 Complement
BSET, BRES	Bit Operations
BTJT, BTJF	Bit Test and Jump Operations
SLL, SRL, SRA, RLC, RRC	Shift and Rotate Operations

SWAP	Swap Nibbles
CALL, JP	Call or Jump subroutine

12.1.7 Relative Mode (Direct, Indirect)

This addressing mode is used to modify the PC register value by adding an 8-bit signed offset to it.

Available Relative Direct/Indirect Instructions	Function
JRxx	Conditional Jump
CALLR	Call Relative

The relative addressing mode consists of two sub-modes:

Relative (Direct)

The offset follows the opcode.

Relative (Indirect)

The offset is defined in memory, of which the address follows the opcode.

INSTRUCTION GROUPS (Cont'd)

Mnemo	Description	Function/Example	Dst	Src	H	I	N	Z	C
ADC	Add with Carry	$A = A + M + C$	A	M	H		N	Z	C
ADD	Addition	$A = A + M$	A	M	H		N	Z	C
AND	Logical And	$A = A \cdot M$	A	M			N	Z	
BCP	Bit compare A, Memory	tst (A . M)	A	M			N	Z	
BRES	Bit Reset	bres Byte, #3	M						
BSET	Bit Set	bset Byte, #3	M						
BTJF	Jump if bit is false (0)	btjf Byte, #3, Jmp1	M						C
BTJT	Jump if bit is true (1)	btjt Byte, #3, Jmp1	M						C
CALL	Call subroutine								
CALLR	Call subroutine relative								
CLR	Clear		reg, M				0	1	
CP	Arithmetic Compare	tst(Reg - M)	reg	M			N	Z	C
CPL	One Complement	$A = FFH - A$	reg, M				N	Z	1
DEC	Decrement	dec Y	reg, M				N	Z	
HALT	Halt					0			
IRET	Interrupt routine return	Pop CC, A, X, PC			H	I	N	Z	C
INC	Increment	inc X	reg, M				N	Z	
JP	Absolute Jump	jp [TBL.w]							
JRA	Jump relative always								
JRT	Jump relative								
JRF	Never jump	jrf *							
JRIH	Jump if ext. interrupt = 1								
JRIL	Jump if ext. interrupt = 0								
JRH	Jump if H = 1	H = 1 ?							
JRNH	Jump if H = 0	H = 0 ?							
JRM	Jump if I = 1	I = 1 ?							
JRNM	Jump if I = 0	I = 0 ?							
JRMI	Jump if N = 1 (minus)	N = 1 ?							
JRPL	Jump if N = 0 (plus)	N = 0 ?							
JREQ	Jump if Z = 1 (equal)	Z = 1 ?							
JRNE	Jump if Z = 0 (not equal)	Z = 0 ?							
JRC	Jump if C = 1	C = 1 ?							
JRNC	Jump if C = 0	C = 0 ?							
JRULT	Jump if C = 1	Unsigned <							
JRUGE	Jump if C = 0	Jmp if unsigned >=							
JRUGT	Jump if (C + Z = 0)	Unsigned >							

INSTRUCTION GROUPS (Cont'd)

Mnemo	Description	Function/Example	Dst	Src	H	I	N	Z	C
JRULE	Jump if (C + Z = 1)	Unsigned <=							
LD	Load	dst <= src	reg, M	M, reg			N	Z	
MUL	Multiply	X,A = X * A	A, X, Y	X, Y, A	0				0
NEG	Negate (2's compl)	neg \$10	reg, M				N	Z	C
NOP	No Operation								
OR	OR operation	A = A + M	A	M			N	Z	
POP	Pop from the Stack	pop reg pop CC	reg CC	M M					
					H	I	N	Z	C
PUSH	Push onto the Stack	push Y	M	reg, CC					
RCF	Reset carry flag	C = 0							0
RET	Subroutine Return								
RIM	Enable Interrupts	I = 0				0			
RLC	Rotate left true C	C <= Dst <= C	reg, M				N	Z	C
RRC	Rotate right true C	C => Dst => C	reg, M				N	Z	C
RSP	Reset Stack Pointer	S = Max allowed							
SBC	Subtract with Carry	A = A - M - C	A	M			N	Z	C
SCF	Set carry flag	C = 1							1
SIM	Disable Interrupts	I = 1				1			
SLA	Shift left Arithmetic	C <= Dst <= 0	reg, M				N	Z	C
SLL	Shift left Logic	C <= Dst <= 0	reg, M				N	Z	C
SRL	Shift right Logic	0 => Dst => C	reg, M				0	Z	C
SRA	Shift right Arithmetic	Dst7 => Dst => C	reg, M				N	Z	C
SUB	Subtraction	A = A - M	A	M			N	Z	C
SWAP	SWAP nibbles	Dst[7..4] <=> Dst[3..0]	reg, M				N	Z	
TNZ	Test for Neg & Zero	tnz lbl1					N	Z	
TRAP	S/W trap	S/W interrupt				1			
WFI	Wait for Interrupt					0			
XOR	Exclusive OR	A = A XOR M	A	M			N	Z	

13.2 ABSOLUTE MAXIMUM RATINGS

Stresses above those listed as “absolute maximum ratings” may cause permanent damage to the device. This is a stress rating only and functional operation of the device under these conditions is not implied. Exposure to maximum rating conditions for extended periods may affect device reliability.

13.2.1 Voltage Characteristics

Symbol	Ratings	Maximum value	Unit
$V_{DD} - V_{SS}$	Supply voltage	6.5	V
$V_{IN}^{1) \& 2)}$	Input Voltage on true open drain pin	$V_{SS}-0.3$ to 6.5	
	Input voltage on any other pin	$V_{SS}-0.3$ to $V_{DD}+0.3$	
$V_{ESD(HBM)}$	Electro-static discharge voltage (Human Body Model)	see Section 13.7.2 "Absolute Electrical Sensitivity" on page 114	
$V_{ESD(MM)}$	Electro-static discharge voltage (Machine Model)		

13.2.2 Current Characteristics

Symbol	Ratings	Maximum value	Unit
I_{VDD}	Total current into V_{DD} power lines (source) ³⁾	80	mA
I_{VSS}	Total current out of V_{SS} ground lines (sink) ³⁾	80	
I_{IO}	Output current sunk by any standard I/O and control pin	25	
	Output current sunk by any high sink I/O pin	50	
	Output current source by any I/Os and control pin	- 25	
$I_{INJ(PIN)}^{2) \& 4)}$	Injected current on ISPSEL pin	± 5	
	Injected current on RESET pin	± 5	
	Injected current on OSC1 and OSC2 pins	± 5	
	Injected current on any other pin ^{5) \& 6)}	± 5	
$\Sigma I_{INJ(PIN)}^{2)}$	Total injected current (sum of all I/O and control pins) ⁵⁾	± 20	

13.2.3 Thermal Characteristics

Symbol	Ratings	Value	Unit
T_{STG}	Storage temperature range	-65 to +150	°C
T_J	Maximum junction temperature (see Section 14.2 "THERMAL CHARACTERISTICS" on page 131)		

Notes:

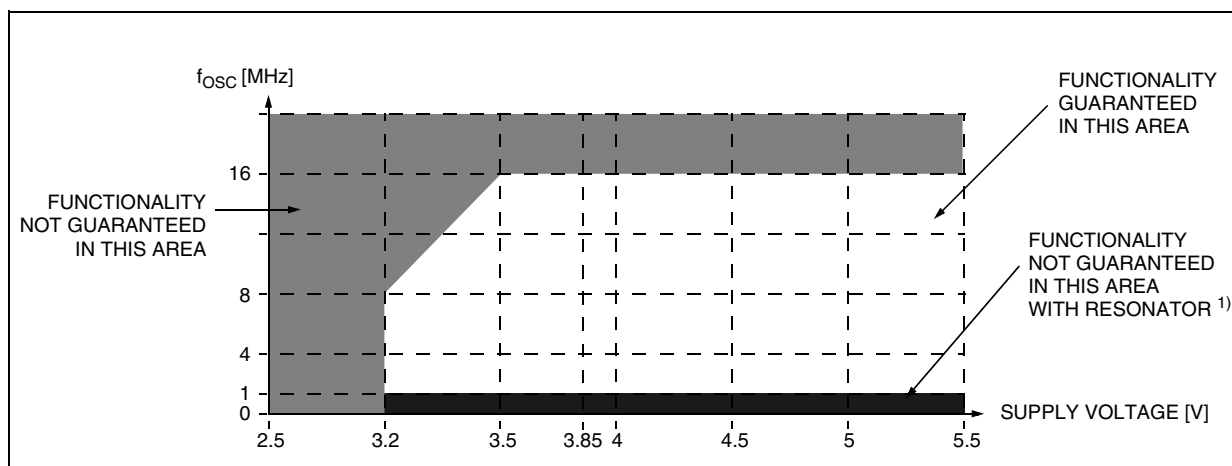
1. Directly connecting the RESET and I/O pins to V_{DD} or V_{SS} could damage the device if an unintentional internal reset is generated or an unexpected change of the I/O configuration occurs (for example, due to a corrupted program counter). To guarantee safe operation, this connection has to be done through a pull-up or pull-down resistor (typical: 4.7kΩ for RESET, 10kΩ for I/Os). Unused I/O pins must be tied in the same way to V_{DD} or V_{SS} according to their reset configuration.
2. When the current limitation is not possible, the V_{IN} absolute maximum rating must be respected, otherwise refer to $I_{INJ(PIN)}$ specification. A positive injection is induced by $V_{IN} > V_{DD}$ while a negative injection is induced by $V_{IN} < V_{SS}$.
3. All power (V_{DD}) and ground (V_{SS}) lines must always be connected to the external supply.
4. Negative injection disturbs the analog performance of the device. In particular, it induces leakage currents throughout the device including the analog inputs. To avoid undesirable effects on the analog functions, care must be taken:
 - Analog input pins must have a negative injection less than 0.8 mA (assuming that the impedance of the analog voltage is lower than the specified limits)
 - Pure digital pins must have a negative injection less than 1.6mA. In addition, it is recommended to inject the current as far as possible from the analog input pins.
5. When several inputs are submitted to a current injection, the maximum $\Sigma I_{INJ(PIN)}$ is the absolute sum of the positive and negative injected currents (instantaneous values). These results are based on characterisation with $\Sigma I_{INJ(PIN)}$ maximum current injection on four I/O port pins of the device.
6. True open drain I/O port pins do not accept positive injection.

13.3 OPERATING CONDITIONS

13.3.1 General Operating Conditions

Symbol	Parameter	Conditions	Min	Max	Unit
V_{DD}	Supply voltage	see Figure 51 and Figure 52	3.2	5.5	V
f_{OSC}	External clock frequency	$V_{DD} \geq 3.5V$ for ROM devices $V_{DD} \geq 4.5V$ for FLASH devices	0 ¹⁾	16	MHz
		$V_{DD} \geq 3.2V$	0 ¹⁾	8	
T_A	Ambient temperature range	1 Suffix Version	0	70	°C
		5 Suffix Version	-10	85	
		6 Suffix Version	-40	85	
		7 Suffix Version	-40	105	
		3 Suffix Version	-40	125	

Figure 51. f_{OSC} Maximum Operating Frequency Versus V_{DD} Supply Voltage for ROM devices ²⁾



OPERATING CONDITIONS (Cont'd)

13.3.2 Operating Conditions with Low Voltage Detector (LVD)

Subject to general operating conditions for V_{DD} , f_{OSC} , and T_A .

Symbol	Parameter	Conditions	Min	Typ ¹⁾	Max	Unit
V_{IT+}	Reset release threshold (V_{DD} rise)	High Threshold Med. Threshold Low Threshold	4.10 ²⁾ 3.75 ²⁾ 3.25 ²⁾	4.30 3.90 3.35	4.50 4.05 3.55	V
V_{IT-}	Reset generation threshold (V_{DD} fall)	High Threshold Med. Threshold Low Threshold ⁴⁾	3.85 ²⁾ 3.50 ²⁾ 3.00	4.05 3.65 3.10	4.30 3.95 3.35	
V_{hyst}	LVD voltage threshold hysteresis	$V_{IT+} - V_{IT-}$	200	250	300	mV
V_{tPOR}	V_{DD} rise time rate ³⁾		0.2		50	V/ms
$t_g(V_{DD})$	Filtered glitch delay on V_{DD} ²⁾	Not detected by the LVD			40	ns

Figure 53. High LVD Threshold Versus V_{DD} and f_{OSC} for FLASH devices³⁾

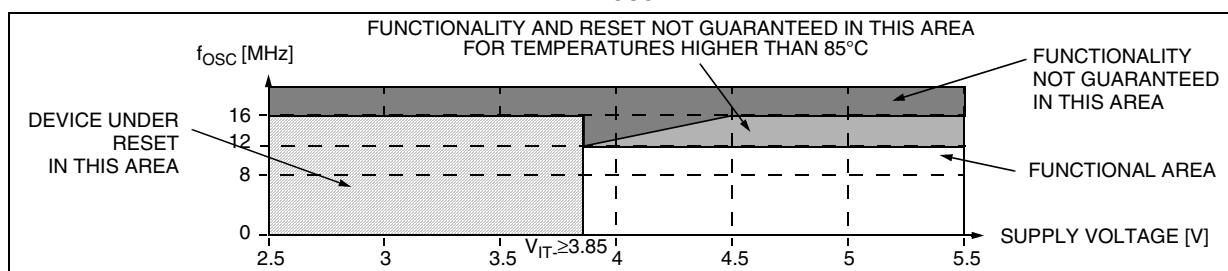


Figure 54. Medium LVD Threshold Versus V_{DD} and f_{OSC} for FLASH devices³⁾

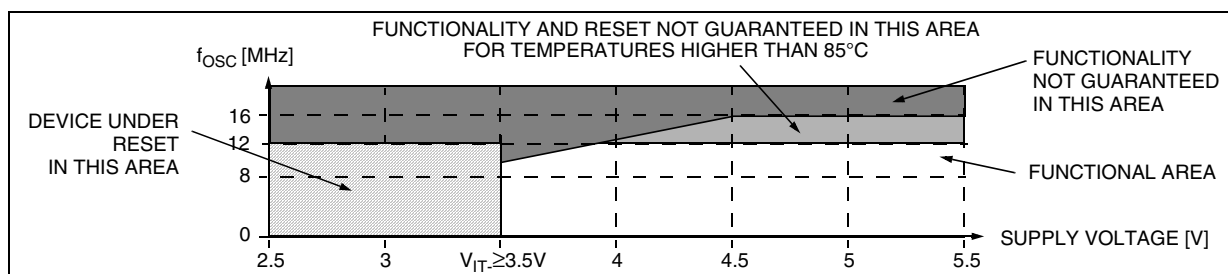
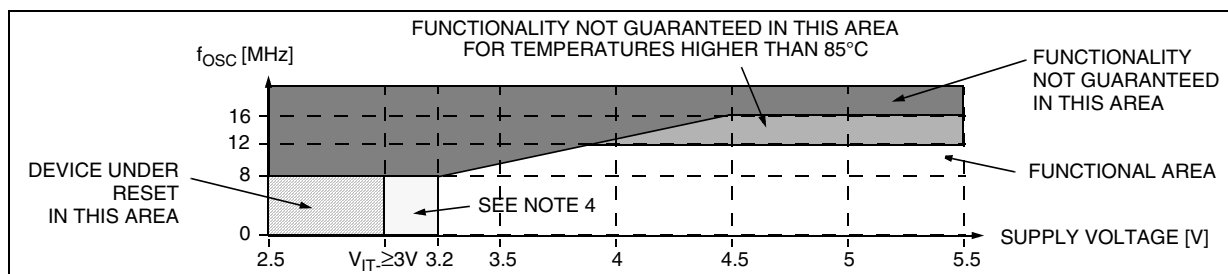


Figure 55. Low LVD Threshold Versus V_{DD} and f_{OSC} for FLASH devices²⁾⁴⁾



Notes:

1. LVD typical data are based on $T_A = 25^\circ\text{C}$. They are given only as design guidelines and are not tested.
2. Data based on characterization results, not tested in production.
3. The V_{DD} rise time rate condition is needed to insure a correct device power-on and LVD reset. Not tested in production.
4. If the low LVD threshold is selected, when V_{DD} falls below 3.2V, (V_{DD} minimum operating voltage), the device is guaranteed to continue functioning until it goes into reset state. The specified V_{DD} min. value is necessary in the device power on phase, but during a power down phase or voltage drop the device will function below this min. level.

EMC CHARACTERISTICS (Cont'd)

True Open Drain Pin Protection

The centralized protection (4) is not involved in the discharge of the ESD stresses applied to true open drain pads due to the fact that a P-Buffer and diode to V_{DD} are not implemented. An additional local protection between the pad and V_{SS} (5a & 5b) is implemented to completely absorb the positive ESD discharge.

Multisupply Configuration

When several types of ground (V_{SS} , V_{SSA} , ...) and power supply (V_{DD} , V_{DDA} , ...) are available for any reason (better noise immunity...), the structure shown in Figure 77 is implemented to protect the device against ESD.

Figure 75. Positive Stress on a True Open Drain Pad vs. V_{SS}

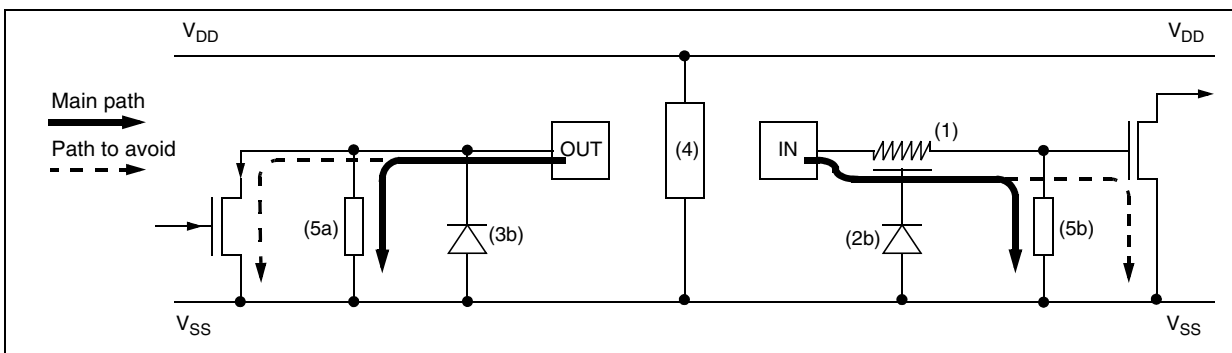


Figure 76. Negative Stress on a True Open Drain Pad vs. V_{DD}

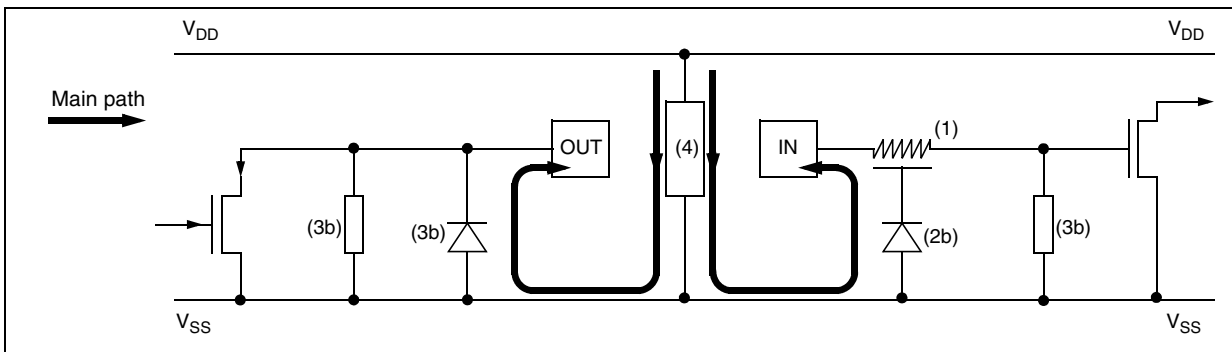
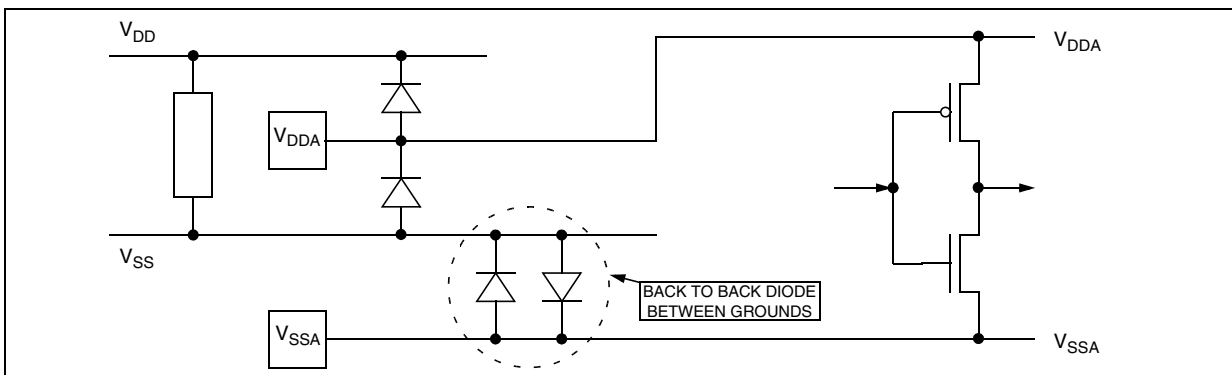


Figure 77. Multisupply Configuration



COMMUNICATION INTERFACE CHARACTERISTICS (Cont'd)

Figure 92. SPI Slave Timing Diagram with $CPHA=1^1$

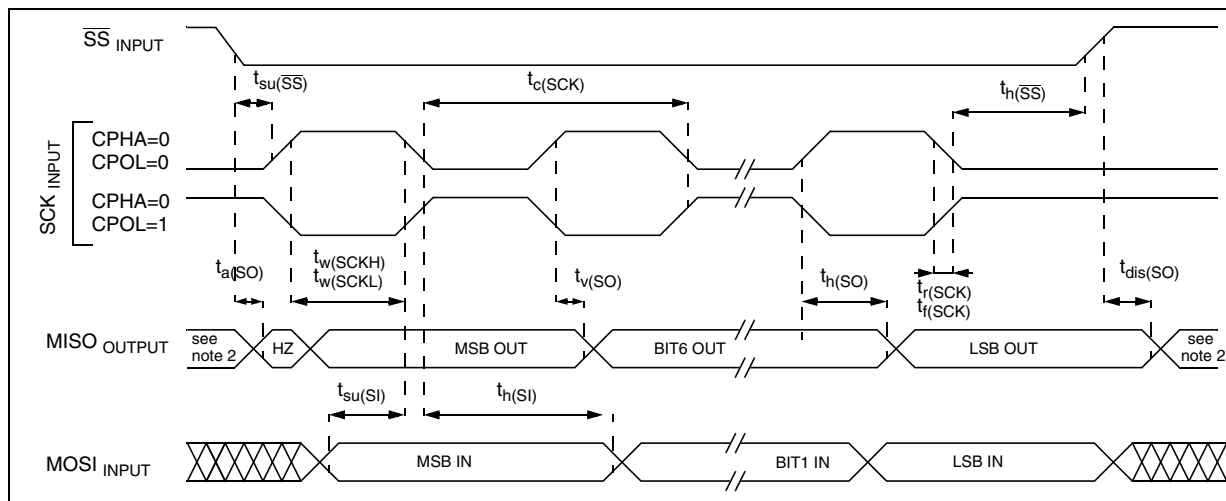
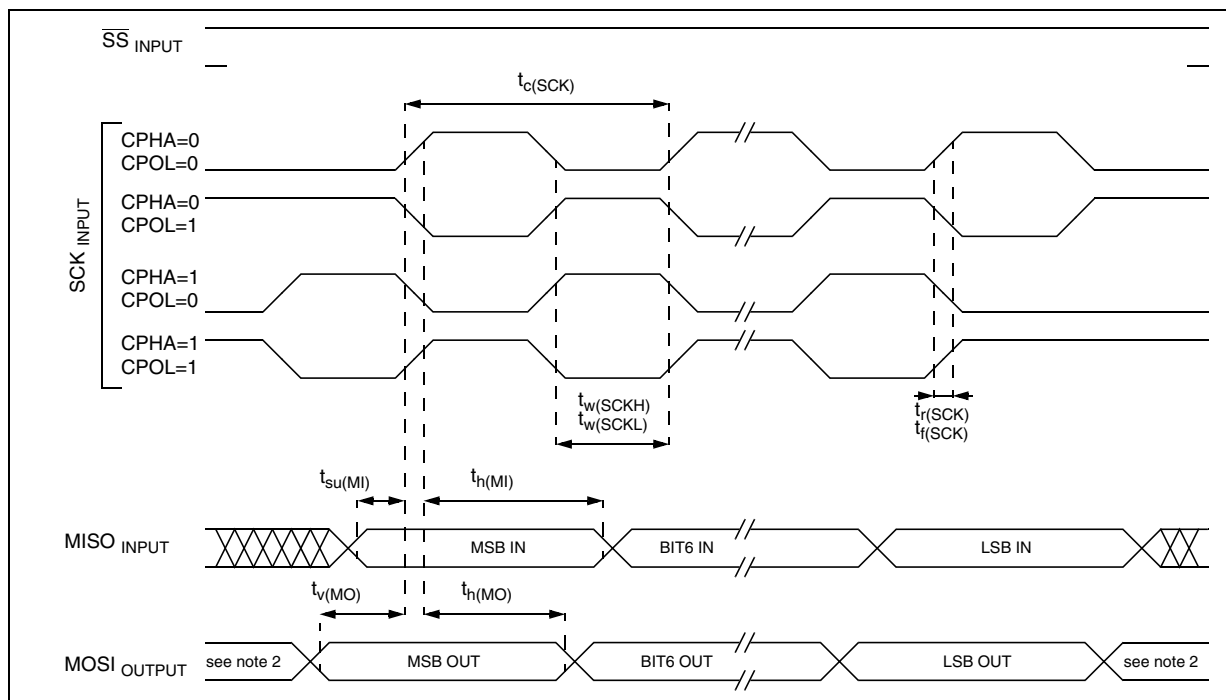


Figure 93. SPI Master Timing Diagram ¹⁾



Notes:

1. Measurement points are done at CMOS levels: $0.3 \times V_{DD}$ and $0.7 \times V_{DD}$.
2. When no communication is on-going the data output line of the SPI (MOSI in master mode, MISO in slave mode) has its alternate function capability released. In this case, the pin status depends of the I/O port configuration.

Signature: